

# HIGH-VOLTAGE LABS TESTING & VALIDATION OF POWER ELECTRONICS.



Greater Performance Improved Quality Increased Lifetime

# Customized Tests for Power Electronics.

Since 2010, we have been dedicated to the electrical validation of next-generation drive electronics and charging technology – offering a complete solution from a single source. From planning, specification, execution, and automation of test cases to fault analysis, we are your reliable and experienced partner.

As experts in development and testing services, we take full responsibility for the complete validation process. This includes comprehensive support for test item qualification, customized adjustments, and precise configurations tailored to your needs.

Leveraging our expertise, we make a significant contribution to the sustainability of energy and mobility solutions. The insights gained from our testing processes lead to improved performance and efficiency of your components.

We look forward to handling your test cases.



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Increasing cost pressure and a rising number of variants require goal-oriented and precise test planning and execution.

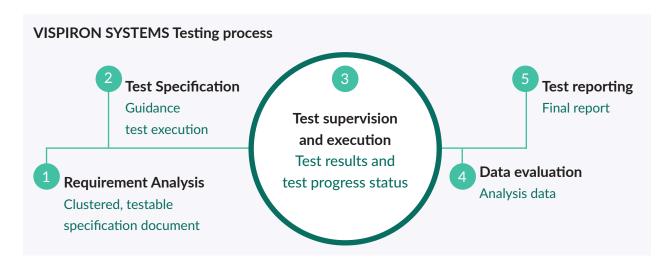
#### What we provide:

- Test planning and management
- Specification of test cases
- Automation of test cases on the test bench
- Execution/supervision
- Error analysis and tracking
- Problem management

#### What we test:

- Power electronics/Inverter
- Charging technologies
- LV-123/HV validation
- LV-124
- Environmental and lifetime qualification
- EMC emission and immunity

We support you in realizing your individual requirements by accompanying you throughout the entire testing process—from requirements analysis to final test reporting, as well as from system-level testing to individual component testing.



### Maximum Flexibility for Maximum Success.



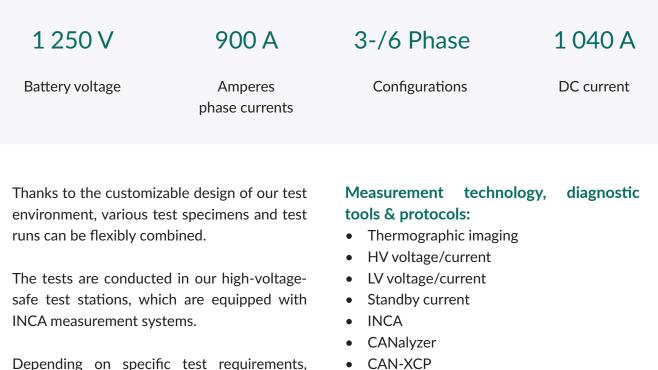
Thanks to our collaboration with selected testing laboratories, we can flexibly adjust our capacities to meet specific customer requirements.





## 8 Testing Stations, 5 Test Systems – Countless Variations.

Our test environment is fully customizable, providing a high degree of flexibility to meet your specific requirements.



LIN

Flexray

CAN/CAN-FD

Depending on specific test requirements, the implementation includes simulations of diverse environmental conditions, such as humidity.

# Specification of Our Test Stations.

| Test Stations             | 1 Power HIL       | Power HIL 7 System test stations |  |  |
|---------------------------|-------------------|----------------------------------|--|--|
| Test Specimen Environment |                   |                                  |  |  |
|                           | Climate chamber   | Temperature Control              |  |  |
| Quantity                  | 5                 | 8 Channels                       |  |  |
| Temperature range         | -70 °C to +120 °C | -40 °C to +90 °C                 |  |  |
| Cooling capacity          | up to 5 kW        | up to 51 kW                      |  |  |
| Flow rate                 | -                 | 22 L/min                         |  |  |
| Volume                    | 1 000 - 1 500 L   | -                                |  |  |
| Humidity control          | 10% to 98%        | -                                |  |  |
| Temperature<br>gradient   | -6 K/min          |                                  |  |  |
|                           | +8 K/min          | _                                |  |  |

#### **Battery Simulations (HV)**

| HVDC-voltage        | up to 1 250 V   |
|---------------------|---|
| Circulating current | up to ±1 440 A  |
| Continuous current  | up to ±1 040 A  |
| Dynamic             | up to ±700 V/ms   |
| Functions           | CC, CV, CR, CP, Ri-Sim, function generator up to 10 kHz |



### E-Machine-Emulator (HV)

| Electrical rotational speed | 1 250+ Hz   |
|-----------------------------|---|
| Number of phases            | 1 x 3 phases/ 1 x 6 phases/ 2 x 3 phases                |
| Multilevel Operation        | 3-Level   |
| Phase current               | to 900 A during continuous operation/ to 1 080 A at 1 s |
| Rotor emulator              | up to 130 A   |
| Rotor position sensor       | AMR/GMR and Resolver                                    |

### Active Stator Load (HV)

| Electrical rotational speed | 200+ Hz  |
|-----------------------------|--|
| Number of pole pairs        | 1 to 25  |
| Number of phases            | 1 x 3 phases/ 1 x 6 phases/ 2 x 3 phases               |
| Phase current               | to 500 A during continuous operation/ to 700 A at 60 s |
| Rotor position sensor       | AMR/GMR and Resolver                                   |
| Switching frequency         | 4 to 14 kHz  |

# Specification of Our Test Stations.

#### **Battery simulations (LV)**

|           | Battsim LV (1)  | Battsim LV (2)   |  |
|-----------|---|--|--|
| Voltage   | -20 V to 80 V   | 0 to 80 V  |  |
| 6         | ±40 A permanent   |  |  |
| Current   | ±75 A for 200 ms  | ±676 A permanent   |  |
| Functions | highly transient voltage profiles,<br>superimposed AC voltage | CC, CV, CR, CP, Ri-Sim,<br>functions generator to 10 kHz |  |
| Donduidth | up to 150 kHz unrestricted                                    | _  |  |
| Bandwidth | up to 250 kHz (40 Vpp max.)                                   |  |  |
| Dimonia   |   | voltage 0% - 90%: to 22 μs                               |  |
| Dynamic   | -   | current -90% - 90%: to 70 µs                             |  |

#### Sensor/Residual Bus Simulation

#### **Residual Bus**

- CAN/CANFD
- Flexray
- LIN
- SENT

#### DACs

- channels up to 18 x isolated
- output voltage up to ±10 V
- output current up to ±20 mA
- dynamics up to 2 µs
- functions: DC, Sinus, Pattern up to 1  $\mu s$



### Fault simulations

|           | FIU HV                    |  |  |
|-----------|---------------------------|--|--|
| Channels  | 6 x AC-lines              |  |  |
|           | 2 x DC-lines              |  |  |
| Functions | Phase short circuits      |  |  |
|           | Line interruption (AC/DC) |  |  |

### **Ripple Generator (HV)**

- Frequency range: 0 to 300 kHz
- Current: up to 400 App
- Power: up to 8 kVArms
- Artificial network according to ISO 21498

|           | FIU LV   |
|-----------|--|
|           | 8 x Power channels (30 A, 60 V)  |
| Channels  | 60 x Signal channels (2 A, 60 V)   |
|           | 8 x Differential channels (2A, 60 V) optimized for different. signals e.g. CAN             |
|           | 2 x Fast Interrupter (1 x 2 A, 1 x 40 A)   |
|           | Fast line interruption (10 μs switching edge) interruption patterns,<br>e.g. loose contact |
| Functions | Short circuits to GND, to Ubat, and between channels                                       |
|           | Automated connection of equipment (e.g. electronic load, multimeter, oscilloscope, etc.)   |

# Technical Information about Existing Sensor Technology.

| Measurement<br>variable | Measurement<br>range | Accuracy                | Measurement type<br>/information   | Sampling<br>frequency |
|-------------------------|----------------------|-------------------------|--|-----------------------|
| Ambient<br>temperature  | -70 to 180 °C        | 0,5 K                   | -  | 1 Sa/s                |
| Ambient<br>humidity     | 10 to 98% r.F.       | ±3 %                    | psychrometric humidity<br>measurement with forced-<br>wetted self-cleaning<br>wet-bulb temperature<br>sensor | -                     |
| Coolant<br>temperature  | -40 to +250 °C       | 0,5 K                   | Pt100  | 1 Sa/s                |
| Coolant<br>flow rate    | 0,2 to 30 L/min      | 1% v.M.<br>at > 2 L/min | Magnetic-inductive<br>flow measurement   | 1 Sa/s                |
| LV voltage              | ±30 V                | 25 mV<br>(0,2 % v.M)    |  | up to<br>1,2 MSa/s    |
|                         | ±48 V                | 6 mV                    | differential, isolated   | up to                 |
|                         | ±100 V               | 20 mV                   |  | 100 kSa/s             |

' 212 SYSTEMS

| Measurement<br>variable         | Measurement<br>range | Accuracy      | Measurement type<br>/information     | Sampling<br>frequency |
|---------------------------------|----------------------|---------------|--------------------------------------|-----------------------|
| HV voltage                      | 0 to 1 200 V         | 0,02% v.E.    | differential, isolated               | up to<br>100 kSa/s    |
| LV currant                      | 1 µA to 100 A        | 1% v.E.       | Shunt with automatic range switching | up to<br>125 kSa/s    |
| AC currant                      | ±3 000 A             | 1% at 1 000 A | Hall effect sensor                   | up to<br>25 kSa/s     |
| DC current                      | ±1 800 A             | 1% at 600 A   | Hall effect sensor                   | up to<br>25 kSa/s     |
| AC/DC<br>current<br>alternative | ±1 000 A             | 0,0054%       | Hall effect sensor                   | up to<br>100 kSa/s    |
| Excitor<br>current              | ±75 A                | 1% at 25 A    | Hall effect sensor                   | up to<br>25 kSa/s     |

This table represents the standard parameters; the measurement technology can be expanded at any time to meet specific requirements.



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#### Competent implementation of individual tests:

**Requirements Analysis** 

- analysis of the product specifications
- requirement assessment and coverage

#### **Test Specification**

- creation of test specifications
- test preparation and planning
- development of test strategies
- consultation on sample phase test scope
- planning of milestones in the coverage scope

#### **Test Execution**

- test status for all test clusters
- performance of electrical tests
- empowerment of test samples on the test system

#### Data Evaluation and Reporting

- summary of partial results from the test clusters
- plausibility check of results
- analysis and evaluation of test results
- preparation of test reports